## Amendments to the Claims

This listing of claims will replace all prior versions, and listings, of claims in the application:
Listing of Claims:

- 1. (Currently Amended) A method for assaying multi-component mixtures comprising:
- a. introducing generating light from a wide-band source of optical radiation and dividing the light into spectral components, and/or extracting selecting the assigned sections of monochromatic light with a spectral width of  $\Delta_i$  from the light in the selected range of wave-lengths  $\lambda_i$  while ensuring the possibility of changing the spectral position of these sections with the assigned pitch  $\Delta\lambda_i \geq \Delta_I$ .
- b. Focusing the <u>extracted\_selected\_monochromatic</u> light <u>ento\_into</u> a probing beam having a specified geometric shape, and directing the light onto a sample under analysis;
- c. Irradiating a sample of a known mixture K to be analyzed and a sample of an unknown mixture U, by turns, with monochromatic light at the assigned wave-lengths  $\lambda_1$ ,  $\lambda_2$ , ...  $\lambda_m$  from the selected spectral range  $\lambda_i$ ;
- d. Collecting light falling onto the sample, passing through the sample, or reflected by the sample, and directing the luminescent light to independent photo-detector devices;

- e. Measuring the intensity values of the light gathered on the photo detector for each of the extracted wavelengths  $\lambda_1$ ,  $\lambda_2$ , ...  $\lambda_m$  of the selected spectral range  $\lambda_i$ , such that, the probing light  $I_0$ , the light passing through a sample or reflected by a sample  $I_T$ , and the luminescence light of a sample  $I_L$ , including steps of decomposition of the luminescent light into a variety of spectral sections, and/or sequential extraction of the specified sections of wave-lengths of  $\lambda_1$ ,  $\lambda_2$ , ...  $\lambda_n$  with a width of  $\Delta_j$ , with the assigned pitch of  $\Delta\lambda_j \geq \Delta_j$ , where each section corresponds with the predetermined . characteristic wave-length of the light in the selected spectral range  $\lambda_j$ , which is gathered and registered by a photodetector is measured;
- f. Defining the relative intensity of the gathered light passing through a sample, or reflected by a sample, at each of extracted wave-lengths  $\lambda_m$ , and the luminescent light for each of the extracted wave-lengths  $\lambda_m$ ,  $\lambda_n$  for a known mixture and unknown mixture, in accordance with the following expressions:

$$T^{K}(\lambda_{m}) = \frac{I_{T}^{K}(\lambda_{m})}{I_{0}^{K}(\lambda_{m})}; \quad T^{U}(\lambda_{m}) = \frac{I_{T}^{U}(\lambda_{m})}{I_{0}^{U}(\lambda_{m})};$$

$$L^{\scriptscriptstyle K}(\lambda_{\scriptscriptstyle m},\lambda_{\scriptscriptstyle n}) = \frac{I_{\scriptscriptstyle L}^{\scriptscriptstyle K}(\lambda_{\scriptscriptstyle m},\lambda_{\scriptscriptstyle n})}{I_{\scriptscriptstyle 0}^{\scriptscriptstyle K}(\lambda_{\scriptscriptstyle m})}; \quad L^{\scriptscriptstyle U}(\lambda_{\scriptscriptstyle m},\lambda_{\scriptscriptstyle n}) = \frac{I_{\scriptscriptstyle L}^{\scriptscriptstyle U}(\lambda_{\scriptscriptstyle m},\lambda_{\scriptscriptstyle n})}{I_{\scriptscriptstyle 0}^{\scriptscriptstyle U}(\lambda_{\scriptscriptstyle m})}, \quad \text{where}$$

 $I_{\scriptscriptstyle T}^{\scriptscriptstyle K}(\lambda_{\scriptscriptstyle m}), I_{\scriptscriptstyle T}^{\scriptscriptstyle U}(\lambda_{\scriptscriptstyle m})$  - intensity values of passing or

reflected light for samples of a known K mixture and an unknown U mixture measured within the specified sections  $\lambda_1$ ,  $\lambda_2$ , ...  $\lambda_m$  of the extracted range of wave-lengths of incident radiation  $\lambda_i$ ;

 $I_L^K(\lambda_m,\lambda_n), I_L^U(\lambda_m,\lambda_n)$  - the luminescent intensity irradiated by a sample of a known K mixture and a sample of an unknown U mixture within the specified sections  $\lambda_1$ ,  $\lambda_2$ , ...  $\lambda_n$  of the extracted range of wave-lengths  $\lambda_j$  with light excitation within the specified sections  $\lambda_1$ ,  $\lambda_2$ , ...  $\lambda_m$  of the extracted range of wave-lengths  $\lambda_i$ ;

 $I_0^K(\lambda_{\it m}), I_0^U(\lambda_{\it m}) \mbox{ - intensity of incident probing}$  radiation falling on the appropriate samples at the time of performing measurements;

g. Comparing the corresponding relative intensity values of the light passing through a sample, or reflected by a sample, onat each of the extracted wave-lengths  $\lambda_m$ , and the luminescent light for each of the extracted wave-lengths  $\lambda_m$ ,  $\lambda_n$  for a known mixture and an unknown mixture, and defining the compliance between the unknown mixture and the certain mixture by the following expression:

$$A = \frac{1}{2} \times \left( \frac{1}{m} \times \sum_{m=1}^{m} \frac{T^{U}(\lambda_{m})}{T^{K}(\lambda_{m})} + \frac{1}{m \times n} \times \sum_{m=1}^{m} \sum_{n=1}^{n} \frac{L^{U}(\lambda_{m}, \lambda_{n})}{L^{K}(\lambda_{m}, \lambda_{n})} \right) = 1 \pm \delta \text{ , where }$$

 $T^{^{K}}(\lambda_{\scriptscriptstyle{m}}), T^{^{U}}(\lambda_{\scriptscriptstyle{m}})$  - intensity values of passing or

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reflected light for samples of a known K mixture and unknown U mixture, standardized for the intensity of incident radiation falling on a sample at the corresponding wave-length;

 $L^{K}(\lambda_{m},\lambda_{n}), L^{U}(\lambda_{m},\lambda_{n})$  - intensity values of the luminescent light irradiated by a sample of a known K mixture and unknown U mixture within the specified sections  $\lambda_{1}$ ,  $\lambda_{2}$ , ...  $\lambda_{n}$  of the extracted range of wave-lengths  $\lambda_{j}$  with light excitation within the specified sections  $\lambda_{1}$ ,  $\lambda_{2}$ , ...  $\lambda_{m}$  of the extracted range of wave-lengths  $\lambda_{i}$ , normalized for intensity of incident radiation falling on a sample at the corresponding wavelength;

m, n - a number of extracted sections with the wavelengths under compared within the selected spectral ranges  $\lambda_i$  and  $\lambda_j,$  accordingly;

 $\delta$  - a value of allowable deflections of the compared values for the unknown mixture being identified from the corresponding values for the similar values of a standard sample of a known mixture;

h. Defining the presence or absence of foreign impurities in the mixture by the following expressions:

$$C_{T}\left(\lambda_{i}\right) = \frac{T^{U}\left(\lambda_{m+1}\right)}{T^{K}\left(\lambda_{m+1}\right)} - \frac{T^{U}\left(\lambda_{m}\right)}{T^{K}\left(\lambda_{m}\right)}; \quad C_{L}\left(\lambda_{i},\lambda_{j}\right) = \frac{L^{U}\left(\lambda_{m+1},\lambda_{n+1}\right)}{L^{K}\left(\lambda_{m+1},\lambda_{n+1}\right)} - \frac{L^{U}\left(\lambda_{m},\lambda_{n}\right)}{L^{K}\left(\lambda_{m},\lambda_{n}\right)};$$

at the same time wherein, if  $C_{\text{T}}(\lambda_{\text{i}}) = C_{\text{L}}(\lambda_{\text{i}}, \lambda_{\text{j}}) = 0 \pm \delta$ , the foreign

impurities in the sample being identified are determined to be absent, and the conclusion about the presence of unwanted contaminations in the mixture under study may be drawn when there are sections wherein if  $C_T(\lambda_i) > 0 \pm \delta$ , and/or  $C_L(\lambda_i, \lambda_j) \neq 0 \pm \delta$ , in the difference spectrathe foreign impurities in the sample are determined to be absent.

- 2. (Currently Amended) A method for analyzing a sample comprising multi-component mixture comprising:
- a. Obtaining an electronic-absorption-luminescent signature of the multicomponent mixture;
- b. Comparing the electronic absorption-luminescent signatures of the sample with the absorption-luminescent signature of a known mixture;
- c. Preparing calibration samples which represent a specially made-up mixture or multi-component solution of a strictly identical constant compoundsuch component, for which the absorption or reflectance spectra, and luminescence spectra of which solution overlap with the corresponding spectra of a certain mixture within the selected analytical spectral ranges  $\lambda_i$  and  $\lambda_j$ , i.e. have nonzero intensity in the specified ranges;
- d. Placing a standard sample of a certain K mixture and a calibration Q sample into an analytical device;

- e. Measuring and transforming measured values for intensity of the light passing through or reflected by standard and calibration samples, and their luminescent light, in accordance with steps a-e of Example 1, while taking into account the step of replacing an unknown U sample with the calibration Q sample;
- f. Creating an electronic absorption-luminescent signature  ${\tt ALS}_{\tt K}$  of a standard sample as follows:

$$ALS_{\scriptscriptstyle{K}} = \left\| K_{\scriptscriptstyle{E}} \right\| = \left\| \left( \frac{T_{\scriptscriptstyle{1}}^{\scriptscriptstyle{K}}}{T_{\scriptscriptstyle{1}}^{\scriptscriptstyle{Q}}} \right) \left( \frac{L_{\scriptscriptstyle{1,1}}^{\scriptscriptstyle{K}}}{L_{\scriptscriptstyle{1,1}}^{\scriptscriptstyle{Q}}} \right) \dots \left( \frac{L_{\scriptscriptstyle{1,n}}^{\scriptscriptstyle{K}}}{L_{\scriptscriptstyle{1,n}}^{\scriptscriptstyle{Q}}} \right) \right\| \text{, where:} \\ \left( \frac{T_{\scriptscriptstyle{m}}^{\scriptscriptstyle{K}}}{T_{\scriptscriptstyle{m}}^{\scriptscriptstyle{Q}}} \right) \left( \frac{L_{\scriptscriptstyle{m,1}}^{\scriptscriptstyle{K}}}{L_{\scriptscriptstyle{m,1}}^{\scriptscriptstyle{Q}}} \right) \dots \left( \frac{L_{\scriptscriptstyle{m,n}}^{\scriptscriptstyle{K}}}{L_{\scriptscriptstyle{m,n}}^{\scriptscriptstyle{Q}}} \right) \right\| \text{,}$$

 $T^{\kappa}(\lambda_m), T^{\mathcal{Q}}(\lambda_m)$  - intensity values of passing or reflected light for a sample of a known K mixture and a sample of a calibration Q mixture, standardized for intensity of incident radiation falling on a sample at the corresponding wave-length;

 $L^{K}(\lambda_{m},\lambda_{n}),L^{Q}(\lambda_{m},\lambda_{n})$  - intensity values of the luminescent light irradiated by a sample of a known K mixture and a calibration Q mixture within the specified sections  $\lambda_{1}$ ,  $\lambda_{2}$ , ...  $\lambda_{n}$  of the extracted range of wave-lengths  $\lambda_{j}$  with light excitation within the specified sections  $\lambda_{1}$ ,  $\lambda_{2}$ , ...  $\lambda_{m}$  of the

extracted range of wave-lengths  $\lambda_i$ , normalized for intensity of incident radiation falling on a sample at the corresponding wave-length;

- g. Entering the electronic signature of a standard sample  ${\rm ALS}_K$  into a computer database, and/or saving the electronic signature of the standard sample on an intermediate medium;
- h. Repeating step (c) with a sample of an unknown mixture, including the step of replacing a standard sample K with a calibration sample Q, which is strictly identical with the calibration sample used when measuring a standard sample, and creating an electronic signature  $ALS_U$  of a sample being identified:

$$ALS_{U} = \left\|\boldsymbol{U}_{E}\right\| = \begin{bmatrix} \left(\frac{T_{1}^{U}}{T_{1}^{\mathcal{Q}}}\right) \left(\frac{L_{1,1}^{U}}{L_{1,1}^{\mathcal{Q}}}\right) \dots \left(\frac{L_{1,n}^{U}}{L_{1,n}^{\mathcal{Q}}}\right) \\ \dots & \dots & \dots \\ \left(\frac{T_{m}^{U}}{T_{m}^{\mathcal{Q}}}\right) \left(\frac{L_{m,1}^{U}}{L_{m,1}^{\mathcal{Q}}}\right) \dots \left(\frac{L_{m,n}^{U}}{L_{m,n}^{\mathcal{Q}}}\right) \end{bmatrix};$$

i. Comparing electronic signatures of an unknown mixture  $\mathrm{ALS}_{\mathtt{U}} = \|U_{\mathtt{E}}\|$  being tested with similar data for a standard sample of a known mixture  $\mathrm{ALS}_{\mathtt{K}} = \|K_{\mathtt{E}}\|$  by the following expression:

$$\left\|A_{ALS}\right\| = \frac{\left\|U_E\right\|}{\left\|K_E\right\|} \ ,$$

such that, a conclusion on the identity of the unknown mixture and the certain mixture may be drawn when all <u>cells elements</u> of the matrix  $\|A_{ALS}\|$  contain only unit elements (i.e.  $a_i = a_{i,j} = 1 \pm \delta$ );

j. Defining the presence or absence of unwanted contaminations for the mixture under study by the following expression:

$$\|C_{ALS}\| = \frac{\|U_E\| - \|K_E\|}{\|K_E\|}$$
 ,

at the same time, a determining the presence of unwanted contaminations in the mixture wherein if the matrix  $\|C_{ALS}\|$  when in the matrix there comprises are nonzero elements, the values of which exceed the value of allowable deflections from the correspondence values of the standard sample of the known  $\max$  ture,  $|c_x, c_{xy}| > |\pm \delta|$ , the values of which exceed the value of allowable deflections of the values being compared for the unknown mixture being identified, from the corresponding values for the similar values of a standard sample of a certain mixture the sample under analysis is determined to contain the unwanted contaminations.

3. (Currently Amended) The method according to claim 1 further comprising measuring intensity values of Raman scattering of the identified sample under analysis and a

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standard sample including the following steps:

- a. irradiating the sample and a known mixture, by turns, with a monochromatic line of a narrow-band (lined) source of light at one or several selected fixed frequencies  $\nu_{\rm r};$
- b. Gathering the light of Raman scattering onto a photo-detector device;
- extracted frequencies  $v_1$ ,  $v_2$ , ...,  $v_p$  of the selected spectral range, gathered onto a photo-detector of the line, namely: the exciting light falling on a sample  $I_{\rm ex}$ , and the light of Raman scattering of a sample  $I_R$ , including steps of decomposition of the light of Raman scattering into a variety of spectral sections, and/or sequential extraction of the specified frequency sections  $v_1$ ,  $v_2$ , ...,  $v_p$  with a width of  $\Delta_r$ , with assigned pitch  $\Delta v_r \ge \Delta_r$ , where each section corresponds to the predetermined characteristic frequency of the light in the selected spectral range  $v_r$ , which is gathered and registered by a photo-detector;
- d. Defining the relative intensity of the gathered light of Raman scattering at each of the extracted frequencies  $v_1$ ,  $v_2$ , ...,  $v_p$  for a known and unknown mixtures in accordance with the following expressions:

$$R^{K}(\nu_{ex},\nu_{p}) = \frac{I_{R}^{K}(\nu_{ex},\nu_{p})}{I_{ex}^{K}}; \quad R^{U}(\nu_{ex},\nu_{p}) = \frac{I_{R}^{U}(\nu_{ex},\nu_{p})}{I_{ex}^{U}};$$

where:

 $I_R^K(\nu_{ex},\nu_p), I_R^U(\nu_{ex},\nu_p)$  - intensity of Raman scattering irradiated by a sample of a known K mixture and a sample of an unknown U mixture within the specified sections  $\nu_1$ ,  $\nu_2$ , ...  $\nu_p$  of the extracted frequency range  $\nu_r$  with light excitation at one of the selected frequencies  $\nu_{ex}$ ;

 $I_{\rm ex}^{\it K}, I_{\rm ex}^{\it U}$  - intensity of the exciting light falling on corresponding samples at the time of performing measurements;

e. Comparing data for the mixture being tested with similar data for a standard sample of a known mixture by the following expression:

$$A = \frac{1}{2} \times \left( \frac{R^{U}(\nu_{ex}, \nu_{p})}{R^{K}(\nu_{ex}, \nu_{p})} \right) \times \left( \frac{1}{m} \times \sum_{m=1}^{m} \frac{T^{U}(\lambda_{m})}{T^{K}(\lambda_{m})} + \frac{1}{m \times n} \times \sum_{m=1}^{m} \sum_{n=1}^{n} \frac{L^{U}(\lambda_{m}, \lambda_{n})}{L^{K}(\lambda_{m}, \lambda_{n})} \right),$$

Wherein the unknown mixture and the known mixture are defined as being identical when—if  $A=1\pm\delta$  .

4. (Currently Amended) The method according to claim 2 comprising comparing electronic signatures containing along with spectral profiles of absorption, luminescence and luminescent intensities, spectral profiles of Raman scattering intensities for the mixture an unknown (RALS $_{\tt U}$ ) and a standard sample (RALS $_{\tt K}$ ), which that electronic signatures are formed by

the method of claim 3, wherein the Raman matrixes are normalized in the following way:

- a. Preparing a calibration sample  $Q_R$ , which calibration sample represents a specially made-up mixture or a multi-component solution of a strictly identical constantsuch compound for which, the luminescence spectrum of which overlaps with the Raman spectrum of the known mixture within the selected analytical spectral ranges;
- b. Measuring the intensity of Raman scattering, and converting the results as in steps b-f of claim 2;
- c. Comparing the signatures of a standard sample and the mixture being identified in accordance with the following expressions:

$$\|K_R\| = \begin{pmatrix} \begin{pmatrix} R_{1,1}^K \\ L_{1,1}^Q \end{pmatrix} \dots \begin{pmatrix} R_{1,p}^K \\ L_{1,p}^K \end{pmatrix} & \text{if } \|U_R\| = \begin{pmatrix} \begin{pmatrix} R_{1,1}^U \\ L_{1,1}^Q \end{pmatrix} \dots \begin{pmatrix} R_{1,p}^U \\ L_{1,p}^Q \end{pmatrix} & \text{where} \\ \begin{pmatrix} R_{q,1}^U \\ L_{q,1}^Q \end{pmatrix} \dots \begin{pmatrix} R_{q,p}^U \\ L_{q,p}^Q \end{pmatrix} & \text{where} \\ \begin{pmatrix} R_{q,1}^U \\ L_{q,1}^Q \end{pmatrix} \dots \begin{pmatrix} R_{q,p}^U \\ L_{q,p}^Q \end{pmatrix} & \text{where} \\ \end{pmatrix}$$

 $R_{q,p}^K, R_{q,p}^U$  - intensity values of Raman light scattering, normalized for intensity of the exciting light  $I_{\rm ex}$ , for samples of the known K mixture and the unknown U mixture, measured at the frequencies  $I_{\rm p}$  with light excitation at the frequency  $I_{\rm q}$ ;

 $L_{q,p}^{\mathcal{Q}_R}$  - the luminescence intensity for a calibration sample  $\mathcal{Q}_R$ , normalized for the intensity of the exciting light  $I_{\mathrm{ex}}$ ;

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d. Pairing the electronic signatures of the mixture  $\|U_E\|$  being tested with similar data for a standard sample of a known mixture  $\|K_E\|$ , including the step of comparing Raman matrixes (RALS<sub>U,K</sub>), by the following expression:

$$\left\|A_{\mathit{RALS}}\right\| = \left(\frac{\left\|U_{R}\right\|}{\left\|K_{R}\right\|}\right) \times \left(\frac{\left\|U_{E}\right\|}{\left\|K_{E}\right\|}\right),$$

where the identity of samples is defined by the following attribute:  $\|A_{RALS}\| = 1 \pm \delta$ .

- 5. (Currently Amended) The method according to claim 1 wherein samples—the sample of the mixture being identified under analysis and the standard mixture are dissolved in appropriate solvents.
- 6. (Currently Amended) The method according to claim 1 wherein the mixture multi-component compound of impurities and/or contaminations in the water system being analyzed is water.